Panasonic Transistor

2SC5474 (Tentative)

Silicon NPN epitaxial planar type

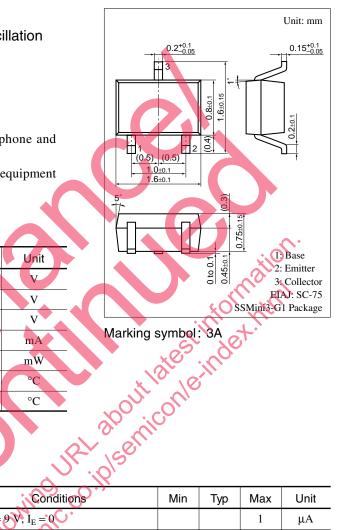
For low-voltage low-noise high-frequency oscillation

■ Features

- High transition frequency f_T
- High gain of 8.9 dB and low noise of 1.8 dB at 3 V
- Optimum for RF amplification of a portable telephone and pager
- SS-Mini type package, allowing downsizing of the equipment and automatic insertion through the tape packing

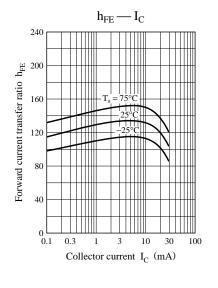
■ Absolute Maximum Ratings $T_a = 25$ °C

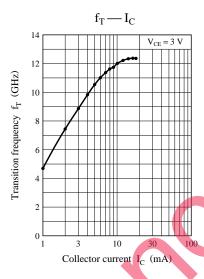
Parameter	Symbol	Rating	Unit
Collector to base voltage	V _{CBO}	9	V
Collector to emitter voltage	V _{CEO}	6	V
Emitter to base voltage	V _{EBO}	1	V
Collector current	$I_{\mathbb{C}}$	30	mA
Collector power dissipation	P _C	125	mŴ
Junction temperature	T_j	125	°C
Storage temperature	T_{stg}	-55 to +125	°C

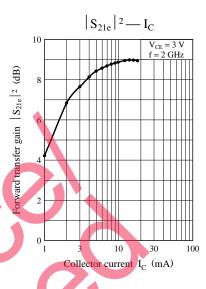


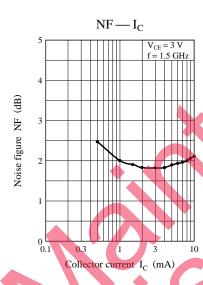
■ Electrical Characteristics $T_a = 25$ °C

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector cutoff current	I_{CBO}	$V_{CB} = 9$ V, $I_E = 0$			1	μΑ
Emitter cutoff current	I_{EBO}	$V_{HB} = 1 \text{ V, I}_{C} = 0$			1	μΑ
Forward current transfer ratio	h _{FE}	$V_{CE} = 3 \text{ V} \cdot I_{C} = 10 \text{ mA}$	80		200	
Collector output capacitance	C _{ob}	$V_{CB} = 3 \text{ V}, I_{E} = 0, f = 1 \text{ MHz}$		0.4		pF
Transition frequency	£\$Q	$V_{CE} = 3 \text{ V}, I_{C} = 10 \text{ mA}, f = 2 \text{ GHz}$		12.0		GHz
Noise figure	ONF X	$V_{CE} = 3 \text{ V}, I_{C} = 3 \text{ mA}, f = 1.5 \text{ GHz}$		1.8		dB
Forward transfer gain	$ S_{21e} ^2$	$V_{CE} = 3 \text{ V}, I_{C} = 10 \text{ mA}, f = 2 \text{ GHz}$		8.9		dB









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